

FDZ298N

N-Channel 2.5 V Specified PowerTrench® BGA MOSFET

General Description

Combining Fairchild's advanced 2.5V specified PowerTrench process with state of the art BGA packaging, the FDZ298N minimizes both PCB space and $R_{\rm DS(ON)}$. This BGA MOSFET embodies a breakthrough in packaging technology which enables the device to combine excellent thermal transfer characteristics, high current handling capability, ultralow profile packaging, low gate charge, and low $R_{\rm DS(ON)}$.

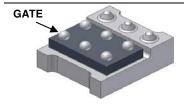
Applications

- · Battery management
- · Battery protection

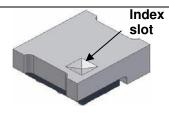
Features

• 6 A, 20 V $R_{DS(ON)} = 27 \ m\Omega \ @V_{GS} = 4.5 \ V$ $R_{DS(ON)} = 39 \ m\Omega \ @V_{GS} = 2.5 \ V$

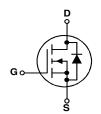
- Occupies only 2.25 mm² of PCB area.
 Less than 50% of the area of a SSOT-6
- Ultra-thin package: less than 0.80 mm height when mounted to PCB
- Outstanding thermal transfer characteristics:
 4 times better than SSOT-6
- Ultra-low Q_g x R_{DS(ON)} figure-of-merit
- High power and current handling capability.







Top



Absolute Maximum Ratings TA=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		20	V
V _{GSS}	Gate-Source Voltage		±12	V
I _D	Drain Current - Continuous	(Note 1a)	6	Α
	– Pulsed		10	
P _D	Power Dissipation for Single Operation	(Note 1a)	1.7	W
T _J , T _{STG}	Operating and Storage Junction Temperat	ture Range	-55 to +150	°C

Thermal Characteristics

R _{0,JA} Thermal Resistance, Junction-to-Ambient	(Note 1a)	72	°C/W
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Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
С	FDZ298N	7"	8mm	3000 units

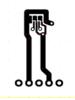
Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics		- I		I.	
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, \qquad I_{D} = 250 \mu\text{A}$	20			V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 16 \text{ V}, \qquad V_{GS} = 0 \text{ V}$			1	μА
I _{GSS}	Gate-Body Leakage.	$V_{GS} = \pm 12 \text{ V}, \qquad V_{DS} = 0 \text{ V}$			±100	nA
On Chara	acteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	0.6	0.9	1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	I_D = 250 μ A,Referenced to 25°C		-0.3		mV/°C
$R_{DS(on)}$	Static Drain–Source On–Resistance	$ \begin{aligned} &V_{GS} = 4.5 \text{ V}, & I_D = 6 \text{ A}, \\ &V_{GS} = 2.5 \text{ V}, & I_D = 5 \text{A}, \\ &V_{GS} = 4.5 \text{ V}, & I_D = 6 \text{ A}, T_J = 125 ^{\circ}\text{C} \end{aligned} $		23 28 28	27 39 42	mΩ
I _{D(on)}	On-State Drain Current	$V_{GS} = 4.5 \text{ V}, \qquad V_{DS} = 5 \text{ V}$	10			Α
g _{FS}	Forward Transconductance	$V_{DS} = 5 V$, $I_D = 6 A$		24		S
Dynamic	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = 10 \text{ V}, \qquad V_{GS} = 0 \text{ V},$ $f = 1.0 \text{ MHz}$		680		pF
Coss	Output Capacitance			165		pF
C_{rss}	Reverse Transfer Capacitance			90		pF
R_{G}	Gate Resistance	$V_{GS} = 15 \text{ mV}, f = 1.0 \text{ MHz}$		1.9		Ω
Switching	Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$ \begin{aligned} V_{DD} &= 10 \ V, & I_D &= 1 \ A, \\ V_{GS} &= 4.5 \ V, & R_{GEN} &= 6 \ \Omega \end{aligned} $		8	16	ns
t _r	Turn-On Rise Time	$V_{GS} = 4.5 \text{ V}, \qquad R_{GEN} = 6 \Omega$		7	14	ns
$t_{\text{d(off)}} \\$	Turn-Off Delay Time			14	26	ns
t _f	Turn-Off Fall Time			6	12	ns
Q_g	Total Gate Charge	$V_{DS} = 10V,$ $I_{D} = 6 A,$		7	10	nC
Q_{gs}	Gate-Source Charge	$V_{GS} = 4.5 \text{ V}$		1.4		nC
Q_{gd}	Gate-Drain Charge			1.8		nC
Drain-So	ource Diode Characteristics	and Maximum Ratings				
Is	Maximum Continuous Drain-Sour	ce Diode Forward Current			1.4	Α
V _{SD}	Drain–Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_S = 1.4 \text{ A} \text{(Note 2)}$		0.7	1.2	V
t _{rr}	Diode Reverse Recovery Time	I _F = 6 A,		14		nS
Q _{rr}	Diode Reverse Recovery Charge	$d_{iF}/d_{t} = 100 \text{ A/}\mu\text{s}$		3		nC

Notes:

S: $R_{0,JA}$ is determined with the device mounted on a 1 in² 2 oz. copper pad on a 1.5 x 1.5 in. board of FR-4 material. The thermal resistance from the junction to the circuit board side of the solder ball, $R_{0,JB}$, is defined for reference. For $R_{0,JC}$, the thermal reference point for the case is defined as the top surface of the copper chip carrier. $R_{0,JC}$ and $R_{0,JB}$ are guaranteed by design while $R_{0,JA}$ is determined by the user's board design.



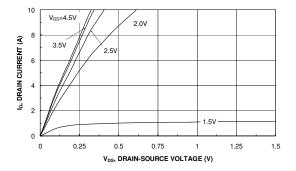
72°C/W when mounted on a 1in² pad of 2 oz copper, 1.5" x 1.5" x 0.062" thick PCB



157°C/W when mounted on a minimum pad of 2 oz copper

Scale 1:1 on letter size paper

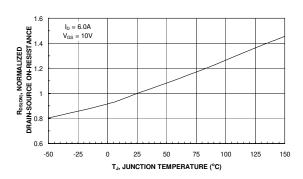
2. Pulse Test: Pulse Width < $300\mu s$, Duty Cycle < 2.0%



2.25 V_{0S} = 2.0V PARAITIZED ON PARAITIZED O

Figure 1. On-Region Characteristics.

Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.



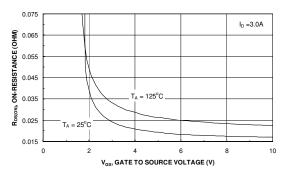
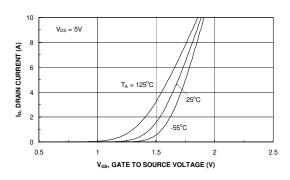


Figure 3. On-Resistance Variation with Temperature.

Figure 4. On-Resistance Variation with Gate-to-Source Voltage.



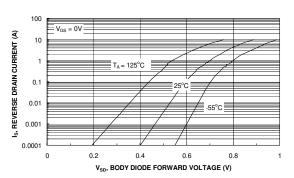
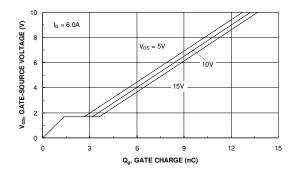


Figure 5. Transfer Characteristics.

Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics



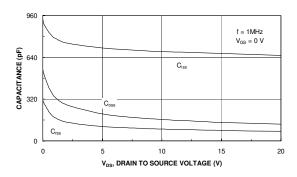


Figure 7. Gate Charge Characteristics.

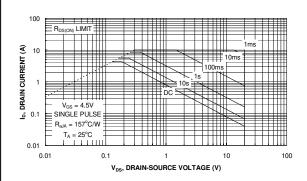


Figure 8. Capacitance Characteristics.

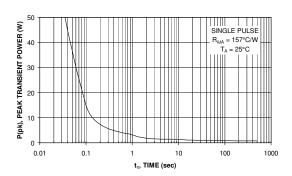


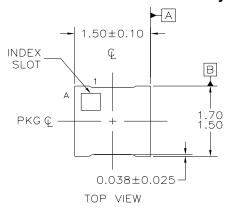
Figure 9. Maximum Safe Operating Area.

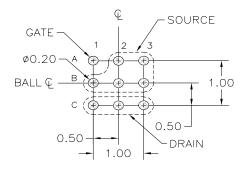
Figure 10. Single Pulse Maximum Power Dissipation.

Figure 11. Transient Thermal Response Curve.

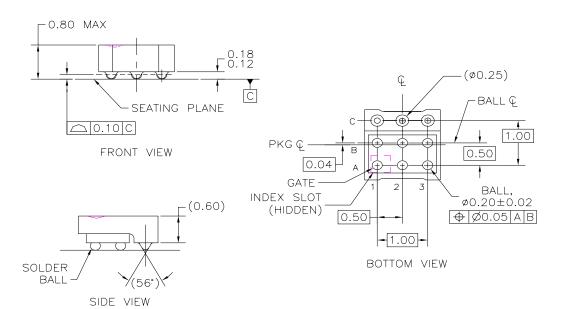
Thermal characterization performed using the conditions described in Note 1b. Transient thermal response will change depending on the circuit board design.

Dimensional Outline and Pad Layout





LAND PATTERN RECOMMENDATION



NOTES: UNLESS OTHERWISE SPECIFIED

- A) ALL DIMENSIONS ARE IN MILLIMETERS.
 B) NO JEDEC REGISTRATION REFERENCE AS OF JULY 1999.
- C) BALL/STUD CONFIGURATION TABLE

TERMINAL ID	DESIGNATION	TERMINAL TYPE
C1,C2,C3	DRAIN	COPPER STUD
A1	GATE	BALL
A2,A3,B1,B2,B3	SOURCE	BALL

BGA06AREVF

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CROSSVOLT™	GlobalOptoisolator™	MicroFET™	PowerTrench®	SuperSOT™-6
DOME™	GTO™ .	MicroPak™	QFET®	SuperSOT™-8
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FACT Quiet Series [™]		OCXPro™	RapidConnect™	UHC™
Across the board. Around the world.™		OPTOLOGIC®	∝SerDes™	UltraFET [®]
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